

100.

SLOVENSKI STANDARD oSIST prEN IEC 61326-2-5:2019

01-oktober-2019

Električna oprema za merjenje, kontrolo in laboratorijsko uporabo - Zahteve za elektromagnetno združljivost (EMC) - 2-5. del: Posebne zahteve - Preskusne konfiguracije, obratovalni pogoji in merila za delovanje terenskih naprav z vmesnikom po IEC 61784-1

Electrical equipment for measurement, control and laboratory use - EMC requirements -Part 2-5: Particular requirements - Test configurations, operational conditions and performance criteria for field devices with field bus interfaces according to IEC 61784-1 **iTeh STANDARD PREVIEW**

(standards.iteh.ai)

Matériel électrique de mesure, de commande et de faboratoire - Exigences relatives à la CEM - Partie 2-5: Exigences particulières - Configurations d'essai, conditions de fonctionnement et critères d'aptitude à la fonction pour les équipements de terrain avec les interfaces utilisant des bus de terrain conformes à la CEI 61784-1

Ta slovenski standard je istoveten z: prEN IEC 61326-2-5:2019

<u>100.</u>		
19.080	Električno in elektronsko preskušanje	Electrical and electronic testing
33.100.01	Elektromagnetna združljivost na splošno	Electromagnetic compatibility in general

oSIST prEN IEC 61326-2-5:2019

2003-01. Slovenski inštitut za standardizacijo. Razmnoževanje celote ali delov tega standarda ni dovoljeno.

en.fr.de

iTeh STANDARD PREVIEW (standards.iteh.ai)

kSIST FprEN IEC 61326-2-5:2020 https://standards.iteh.ai/catalog/standards/sist/d944569c-773a-424e-b224-3a772a2679c2/ksist-fpren-iec-61326-2-5-2020



65A/927/CDV

COMMITTEE DRAFT FOR VOTE (CDV)

PROJECT NUMBER:		
IEC 61326-2-5 ED3		
DATE OF CIRCULATION:	CLOSING DATE FOR VOTING:	
2019-08-23	2019-11-15	
SUPERSEDES DOCUMENTS:		
65A/908/CD, 65A/918A/CC		

IEC SC 65A: SYSTEM ASPECTS		
SECRETARIAT:	SECRETARY:	
United Kingdom	Mr Petar Luzajic	
OF INTEREST TO THE FOLLOWING COMMITTEES:	PROPOSED HORIZONTAL STANDARD:	
TC 77, SC 77A		
	Other TC/SCs are requested to indicate their interest, if any, in this CDV to the secretary.	
FUNCTIONS CONCERNED:		
EMC ENVIRONMENT	QUALITY ASSURANCE SAFETY	
SUBMITTED FOR CENELEC PARALLEL VOTING	Not SUBMITTED FOR CENELEC PARALLEL VOTING	
(standards.iteh.ai)		
Attention IEC-CENELEC parallel voting		
The attention of IEC National Committees Smempers loc CENELEC, is drawn to the fact that this Committee Drattifor Voten (CDV) is submitted for parallel voting. 3a772a2679c2/ksist-fpro	<u>61326-2-5:2020</u> ds/sist/d944569c-773a-424e-b224- n-iec-61326-2-5-2020	
The CENELEC members are invited to vote through the CENELEC online voting system.		

This document is still under study and subject to change. It should not be used for reference purposes.

Recipients of this document are invited to submit, with their comments, notification of any relevant patent rights of which they are aware and to provide supporting documentation.

TITLE:

Electrical equipment for measurement, control and laboratory use – EMC requirements – Part 2-5: Particular requirements – Test configurations, operational conditions and performance criteria for field devices with field bus interfaces according to IEC 61784-1

PROPOSED STABILITY DATE: 2023

NOTE FROM TC/SC OFFICERS:

Copyright © **2019 International Electrotechnical Commission, IEC**. All rights reserved. It is permitted to download this electronic file, to make a copy and to print out the content for the sole purpose of preparing National Committee positions. You may not copy or "mirror" the file or printed version of the document, or any part of it, for any other purpose without permission in writing from IEC.

1

CONTENTS

2	FO	REWC	RD	3
3	1	Scop	e	5
4	2	Norm	ative references	5
5	3	Term	s and definitions	6
6	4	Gene	ral	6
7	5	EMC	test plan	6
8		5.1	General	6
9		5.2	Configuration of EUT during testing	6
10		5.3	Operation conditions of EUT during testing	6
11		5.4	Specification of functional performance	6
12	•	5.5	Test description	6
13	6	Immu	nity requirements	6
14		6.1	Conditions during the tests	6
15 10		6.2	Immunity test requirements	6
10 17		0.3 6.4	Random aspects	0
17 18	7	0.4 Emise	renormance chiena	/
10	, 8	Test	results and test report TANDARD PREVIEW	7
20	9	Instru	ictions for use (standards itab si)	7
 21	Δnr		(normative) Particular requirements – Test configurations, operational	
22 23	con to I	ditions EC 61	s and performance criteria for field devices with field bus interfaces according 784-1 CP_1/1 bttps://standards.iteh.a/catalog/standards/sist/d944569c-773a-474e-b224-	8
24 25 26	Anr con to I	nex BE idition: EC 61	(normative) Particular requirements on Test configurations, operational s and performance criteria for field devices with field bus interfaces according 784-1 CP 3/2	13
27				
28	Fig	ure AA	1.1 – Test set up for EUT with CP 1/1 interface	10
29	Fig	ure BE	3.1 – Test set up for EUT with CP 3/2 interface	15

30

IEC CDV 61326-2-5 © IEC 2019 - 3 -

31	INTERNATIONAL ELECTROTECHNICAL COMMISSION
32 33 34 35 36 37 38 39 40 41 42 43	ELECTRICAL EQUIPMENT FOR MEASUREMENT, CONTROL AND LABORATORY USE – EMC REQUIREMENTS – Part 2-5: Particular requirements – Test configurations, operational conditions and performance criteria for field devices with field bus interfaces according to IEC 61784-1 FOREWORD
44 45 46 47 48 49 50 51 52 53 54	 The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprisin all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. T this end and in addition to other activities, IEC publishes International Standards, Technical Specifications Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IE Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interestee in the subject dealt with may participate in this preparatory work. International, governmental and nor governmental Organizations for Standardization (ISO) in accordance with conditions determined be agreement between the two organizations. The formal decisions or arregements of IEC on technical matters everys as nearly as possible, an international construction.
55 56 57	 interested IEC National Committees. Standards.iten.ai) IEC Publications have the form of recommendations for international use and are accepted by IEC National Committees.
58 59 60 61	Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IE Publications is accurate, IEC cannot be held responsible for the way in which they are used or for an misinterpretation by any endusers itch alcatalog/standards/sist/094569c-773a-424e-b224- 377722670-2/ksist-force-icc_61326-2-5-2020 In order to promote international uniformity, IEC National Committees undertake to apply IEC Publication
62 63 64	transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter.
65 66 67) IEC itself does not provide any attestation of conformity. Independent certification bodies provide conformit assessment services and, in some areas, access to IEC marks of conformity. IEC is not responsible for ar services carried out by independent certification bodies.
68 69 70 71 72 73	 All users should ensure that they have the latest edition of this publication. No liability shall attach to IEC or its directors, employees, servants or agents including individual experts an members of its technical committees and IEC National Committees for any personal injury, property damage of other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) an expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IE Publications.
74 75) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications indispensable for the correct application of this publication.
76 77) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.
78 79 80	nternational Standard IEC 61326-2-5 has been prepared by subcommittee 65A: Syster spects, of IEC technical committee 65: Industrial-process measurement, control an utomation.
81 82	his third edition cancels and replaces the second edition published in 2012. This editio onstitutes a technical revision.

83

- 4 -

65A/927/CDV

- 84 The main technical changes with regard to the previous edition are as follows:
- 85 Update with respect to IEC 61326-1:20xx.
- 86 The text of this standard is based on the following documents:

FDIS	Report on voting
65A/xxx/FDIS	65A/xxx/RVD

87

Full information on the voting for the approval of this standard can be found in the report onvoting indicated in the above table.

90 This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

This part of IEC 61326 series is to be used in conjunction with IEC 61326-1:20xx and follows the same numbering of clauses, subclauses, tables and figures.

93 When a particular subclause of IEC 61326-1 is not mentioned in this part, that subclause 94 applies as far as is reasonable. When this standard states "addition", "modification" or 95 "replacement", the relevant text in IEC 61326-1 is to be adapted accordingly.

- 96 NOTE The following numbering system is used:
- 97 subclauses, tables and figures that are numbered starting from 101 are additional to those in IEC 61326-1;
- 99 unless notes are in a new subclause or involve notes in IEC 61326-1, they are numbered starting from 101 including those in a replaced clause or subclause;
- 101 additional annexes are lettered AA, BB, etc.
 - <u>kSIST FprEN IEC 61326-2-5:2020</u>
- A list of all parts of <u>ALECI61326</u> series stunder the general stille <u>AElectrical</u> equipment for measurement, control and <u>Iaboratory</u> usest-for <u>EMC</u> requirements can be found on the IEC website.

105 The committee has decided that the contents of this publication will remain unchanged until 106 the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data 107 related to the specific publication. At this date, the publication will be

- 108 reconfirmed,
- 109 withdrawn,
- 110 replaced by a revised edition, or
- 111 amended.
- 112
- 113
- 114

IEC CDV 61326-2-5 © IEC 2019

- 5 -

65A/927/CDV

115 116 117 118 119 120 121	ELECTRICAL EQUIPMENT FOR MEASUREMENT, CONTROL AND LABORATORY USE – EMC REQUIREMENTS – Part 2-5: Particular requirements – Test configurations, operational conditions and performance criteria for field devices with field bus interfaces according to IEC 61784-1
122 123 124	
125	1 Scope
126 127 128	In addition to the requirements of International Standard IEC 61326-1:20xx, this part of IEC 61326 series treats the particular features for EMC testing of field devices with field bus interfaces. This part of IEC 61326 covers only the field bus interface of the equipment.
129	NOTE The other functions of the equipment remain covered by other parts of IEC 61326 series.
130 131	This part refers only to field devices intended for use in process control and process measuring.
132 133 134	In this standard field devices with interfaces according to IEC 61784-1:2014, CP 3/2 and CP 1/1 as defined in IEC 61784 are covered. Other field busses may be included in future editions of this standard. (standards.iteh.ai)
135 136	The IEC 61784-1:2014 specifies a set of protocol specific communication profiles based on IEC 61158. <u>kSIST FprEN IEC 61326-2-5:2020</u> https://standards.iteh.ai/catalog/standards/sist/d944569c-773a-424e-b224-
107	The manufacturer aposition 3977222079224ksistaforen-ics-6132642-5-2020 ust is intended to be used

137 The manufacturer specifies the environment for which the product is intended to be used 138 and/or selects the appropriate test level specifications of IEC 61326-1.

139 2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

144 Clause 2 of IEC 61326-1:20xx applies except as follows:

145 Addition:

146 IEC 61158-2:2014, Industrial communication networks – Fieldbus specifications – Part 2:
 147 Physical layer specification and service definition

148 IEC 61158-3-3:2014, Industrial communication networks – Fieldbus specifications – Part 3-3:
 149 Data-link layer service definition – Type 3 elements

150 IEC 61158-5-5:2014, Industrial communication networks – Fieldbus specifications – Part 5-5:
 151 Application layer service definition – Type 5 elements

152 IEC 61158-6-10:2014, Industrial communication networks – Fieldbus specifications – Part 6-

153 10: Application layer protocol specification – Type 10 elements

	65A/927/CDV – 6 – IEC CDV 61326-2-5 © IEC 2019
154	IEC 61784-1:2014. Industrial communication networks – Profiles – Part 1: Fieldbus profiles
	,,,,,,,,,,,,,,,,,,,,
155	3 Terms and definitions
156	Clause 3 of IEC 61326-1:20xx applies.
157	4 General
158	Clause 4 of IEC 61326-1:20xx applies.
159	5 EMC test plan
160	5.1 General
161	Subclause 5.1 of IEC 61326-1:20xx applies.
162	5.2 Configuration of EUT during testing
163	Subclause 5.2 of IEC 61326-1:20xx applies, except as follows:
164	Addition:
165	Additional requirements: see Annexes AA and BB. (standards.iteh.ai)
166	5.3 Operation conditions of EUT during testing
167	Subclause 5.3 of IEC 61326-1:20xx applies, except as follows:
168	Addition: 3a7/2a26/9c2/ksist-tpren-iec-61326-2-5-2020
169	Additional requirements: see Annexes AA and BB.
170	5.4 Specification of functional performance
171	Subclause 5.4 of IEC 61326-1:20xx applies.
172	5.5 Test description
173	Subclause 5.5 of IEC 61326-1:20xx applies.
174	6 Immunity requirements
175	6.1 Conditions during the tests
176	Subclause 6.1 of IEC 61326-1:20xx applies.
177	6.2 Immunity test requirements
178	Subclause 6.2 of IEC 61326-1:20xx applies.

- 179 6.3 Random aspects
- 180 Subclause 6.3 of IEC 61326-1:20xx applies.

IEC CDV 61326-2-5 © IEC 2019 - 7 -

65A/927/CDV

181 6.4 Performance criteria

- 182 Subclause 6.4 of IEC 61326-1:20xx applies, except as follows:
- 183 Addition:
- 184 Additional requirements: see Annexes AA and BB.

185 **7 Emission requirements**

186 Clause 7 of IEC 61326-1:20xx applies.

187 8 Test results and test report

- 188 Clause 8 of IEC 61326-1:20xx applies, except as follows:
- 189 Addition:
- 190 The type of shield connection at the EUT shall be stated in the test report.

191	9	Instructions for use iTeh STANDARD PREVIEW
192	Cla	use 9 of IEC 61326-1:20xx applies. (standards.iteh.ai)

193

kSIST FprEN IEC 61326-2-5:2020 https://standards.iteh.ai/catalog/standards/sist/d944569c-773a-424e-b224-3a772a2679c2/ksist-fpren-iec-61326-2-5-2020 - 8 -

IEC CDV 61326-2-5 © IEC 2019

 Annex AA (normative)
 Particular requirements –
 Test configurations, operational conditions and performance criteria for field devices with field bus interfaces according to IEC 61784-1 CP 1/1

201 AA.1 General

In connection with the main part of this standard, this Annex AA describes specific test configurations, operational conditions and performance criteria regarding the field bus interface using the communication profile CP 1/1 according to IEC 61784-1:2014.

To prevent confusion with requirements of other annexes, the equipment under test (EUT) is called "EUT with CP 1/1 interface" throughout this annex.

207 AA.2 EMC test plan

208 AA.2.1 Configuration of EUT with CP 1/1 interface during testing

- 209 Subclause 5.2 of IEC 61326-1:20xx applies, except as follows:
- 210 Addition:

(standards.iteh.ai)

211 AA.2.1.1 Test configuration for EUT with CP 1/1 interface

In order to assign any malfunction of the communication during the EMC-test to the EUT with
 CP 1/1 interface, the configuration of field devices with interfaces according to IEC 61784 1:2014, CP 1/1 shall be limited to the operation of one host system and one EUT with CP 1/1
 interface during EMC type tests.

Ports other than I/O ports covered by this part of the standard are tested according to IEC 61326-1:20xx.

- 218 The connection plan is shown in Figure AA.1.
- The field device is connected via a device coupler with the power conditioner and the host system.
- A standardised field bus terminator is attached at the third port of the device coupler.

The EUT with CP 1/1 interface, power conditioner, host system, device coupler(s) and terminator are connected by means of a standard type A field bus cable (foil shield, foil shield/mesh). Armoured cables or cables in conduit are not allowed for EMC testing.

Except for the connection at the EUT with CP 1/1 interface itself (see AA.2.1.3), the shield shall be connected at any individual component by a low-impedance grounding strip (connection between shield and the case with a large surface).

The individual cable lengths L1, L2, L3, L5 and L6 originate from a practice-adjusted set up, preferred as given in Figure AA.1.